



Final Product/Process Change Notification

Document #:FPCN24896Z1

Issue Date:28 Jun 2024

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| Title of Change: | Update of FPCN24896Z (The addition of JCET, China as an assembly and test operation for the DPAK package (Case Outline 369C) to provide capacity flexibility): Include the addition of Tongling Landun Poongsan PMC90 Lead Frame supplier. |
| Proposed Changed Material First Ship Date: | 30 Oct 2024 or earlier if approved by customer |
| Current Material Last Order Date: | N/A <i>Orders received after the Current Material Last Order Date expiration are to be considered as orders for new changed material as described in this PCN. Orders for current (unchanged) material after this date will be per mutual agreement and current material inventory availability.</i> |
| Current Material Last Delivery Date: | N/A <i>The Current Material Last Delivery Date may be subject to change based on build and depletion of the current (unchanged) material inventory</i> |
| Product Category: | Active components – Integrated circuits |
| Contact information: | Contact your local onsemi Sales Office or Jolo.Manga@onsemi.com |
| PCN Samples Contact: | Contact your local onsemi Sales Office to place sample order. Sample requests are to be submitted no later than 45 days after publication of this change notification. Samples delivery timing will be subject to request date, sample quantity and special customer packing/label requirements. |
| Sample Availability Date: | 31 May 2024 |
| PPAP Availability Date: | 19 Apr 2024 |
| Additional Reliability Data: | Contact your local onsemi Sales Office or MohdAzizi.Azman@onsemi.com |
| Type of Notification: | This is a Final Product/Process Change Notification (FPCN) sent to customers. The change will be implemented at 'Proposed Change Material First Ship Date' in compliance to J-STD-46 or ZVEI, or earlier upon customer approval, or per our signed agreements. onsemi will consider this proposed change and it's conditions acceptable, unless an inquiry is made in writing within 45 days of delivery of this notice. To do so, contact PCN.Support@onsemi.com . |
| Change Category | |
| Category | Type of Change |
| Test Flow | Move of all or part of electrical wafer test and/or final test to a different location/site/subcontractor |
| Process - Assembly | Move of all or part of assembly to a different location/site/subcontractor., Change of mold compound, Die attach material, Change of direct material supplier |
| Description and Purpose: onsemi would like to inform our customers of the addition of JCET, China for assembly and test of the DPAK package (Case Outline 369C) to enable capacity flexibility. Product bill of material changes are shown in the table below, and all products continue to meet electrical specification requirements listed in the product datasheet. This change is for capacity flexibility, so future deliveries will be sourced from JCET, China, or any of the previously qualified assembly & test locations at the discretion of our supply chain. | |

| Description | Before Change | After Change | |
|----------------------|--|--|--|
| Assembly / Test Site | onsemi, Seremban, Malaysia | onsemi, Seremban, Malaysia | JCET Semiconductor Co.Ltd., Suqian, China |
| LeadFrame (supplier) | ICDPAK 3 lead Bare Copper Poongsan PMC90 | ICDPAK 3 lead Bare Copper Poongsan PMC90 | TO-252-2L(6R)-B Bare Copper Tongling Landun Poongsan PMC90 |
| Die Attach | Solder: 95% Pb 5%Sn | Solder: 95% Pb 5%Sn | Solder: 92.5%Pb, 5%Sn,2.5%Ag |
| Mold Compound | G700HF GE 8000CH4ES | G700HF GE 8000CH4ES | G700HF |

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| Reason / Motivation for Change: | Source/Supply/Capacity Changes Process/Materials Change |
| Anticipated impact on fit, form, function, reliability, product safety or manufacturability: | <p>The device has been qualified and validated based on the same Product Specification. The device has successfully passed the qualification tests. Potential impacts can be identified, but due to testing performed by onsemi in relation to the PCN, associated risks are verified and excluded.</p> <p>No anticipated impacts.</p> |

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|------------------------|--------------------------------------|
| Sites Affected: | |
| onsemi Sites | External Foundry/Subcon Sites |
| None | JCET, China |

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| Marking of Parts/ Traceability of Change: | Changed material can be identified by assembly plant code. |
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Reliability Data Summary:

QV DEVICE NAME: NCV4274ADT50RKG-IR01

RMS: S88331/S93280

PACKAGE: DPAK 369C

| Test | Specification | Condition | Interval | Results |
|---|------------------------|--|----------|---------|
| High Temperature Operating Life | JESD22-A108 | Ta=125°C, 100 % max rated Vcc | 1008 hrs | 0/231 |
| High Temperature Storage Life | JESD22-A103 | Ta= 150°C | 1008 hrs | 0/231 |
| Low Temperature Storage Life | JESD22-A119 | Ta= -40°C | 168 hrs | 0/75 |
| Early Life Failure Rate | JESD22-A108 | Ta=125°C, 100 % max rated Vcc | 48 hrs | 0/2400 |
| Preconditioning | J-STD-020 JESD-A113 | MSL 1 @ 260 °C, Pre TC, uHAST, HAST, PTC for surface mount pkgs only | | 0/828 |
| Temperature Cycling | JESD22-A104 | Ta= -65°C to +150°C, mount on board | 500 cyc | 0/231 |
| Power Temperature Cycling | JESD22-A105 | Ta= -40°C to +125°C, mount on board | 500 cyc | 0/135 |
| Highly Accelerated Stress Test | JESD22-A110 | 130°C, 85% RH, 18.8psig, bias | 96 hrs | 0/231 |
| Unbiased Highly Accelerated Stress Test | JESD22-A118 | 130°C, 85% RH, 18.8psig, unbiased | 96 hrs | 0/231 |
| Resistance to Solder Heat | JESD22- B106 | Ta = 265°C, 10 sec Required for through hole devices only | | 0/90 |
| Solderability | JSTD002 | Ta = 245°C, 5 sec | | 0/45 |

QV DEVICE NAME: NCV4274CDT50RKG

RMS: S88333

PACKAGE: DPAK 369C

| Test | Specification | Condition | Interval | Results |
|---|------------------------|---|----------|---------|
| High Temperature Operating Life | JESD22-A108 | Ta=125°C, 100 % max rated Vcc | 1008 hrs | 0/77 |
| High Temperature Storage Life | JESD22-A103 | Ta= 150°C | 1008 hrs | 0/77 |
| Low Temperature Storage Life | JESD22-A119 | Ta= -40°C | 168 hrs | 0/25 |
| Early Life Failure Rate | JESD22-A108 | Ta=125°C, 100 % max rated Vcc | 48 hrs | 0/800 |
| Preconditioning | J-STD-020 JESD-A113 | MSL 1 @ 260 °C, Pre TC, uHAST, HAST, PTC for surface mount pkgs only | | 0/308 |
| Temperature Cycling | JESD22-A104 | Ta= -55°C to +150°C, mount on board | 1000 cyc | 0/77 |
| Power Temperature Cycling | JESD22-A105 | Ta= -40°C to +125°C, mount on board | 1000 cyc | 0/45 |
| Highly Accelerated Stress Test | JESD22-A110 | 130°C, 85% RH, 18.8psig, bias | 96 hrs | 0/77 |
| Unbiased Highly Accelerated Stress Test | JESD22-A118 | 130°C, 85% RH, 18.8psig, unbiased | 96 hrs | 0/77 |
| Resistance to Solder Heat | JESD22- B106 | Ta = 265°C, 10 sec Required for through hole devices only | | 0/30 |
| Solderability | JSTD002 | Ta = 245°C, 5 sec | | 0/15 |

QV DEVICE NAME: NCV1117DT50RKG

RMS: S88309/S94782

PACKAGE: DPAK 369C

| Test | Specification | Condition | Interval | Results |
|---|------------------------|---|----------|---------|
| High Temperature Operating Life | JESD22-A108 | Ta=125°C, 100 % max rated Vcc | 1008 hrs | 0/231 |
| High Temperature Storage Life | JESD22-A103 | Ta= 150°C | 1008 hrs | 0/231 |
| Low Temperature Storage Life | JESD22-A119 | Ta= -40°C | 168 hrs | 0/75 |
| Early Life Failure Rate | JESD22-A108 | Ta=125°C, 100 % max rated Vcc | 48 hrs | 0/2400 |
| Preconditioning | J-STD-020 JESD-A113 | MSL 1 @ 260 °C, Pre TC, uHAST, HAST, PTC for surface mount pkgs only | | 0/828 |
| Temperature Cycling | JESD22-A104 | Ta= -65°C to +150°C, mount on board | 500 cyc | 0/231 |
| Highly Accelerated Stress Test | JESD22-A110 | 130°C, 85% RH, 18.8psig, bias | 96 hrs | 0/231 |
| Unbiased Highly Accelerated Stress Test | JESD22-A118 | 130°C, 85% RH, 18.8psig, unbiased | 96 hrs | 0/231 |
| Resistance to Solder Heat | JESD22- B106 | Ta = 265°C, 10 sec Required for through hole devices only | | 0/90 |
| Solderability | JSTD002 | Ta = 245°C, 5 sec | | 0/45 |



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NOTE: AEC-1pager is attached.

To view attachments:

1. Download pdf copy of the PCN to your computer
2. Open the downloaded pdf copy of the PCN
3. Click on the paper clip icon available on the menu provided in the left/bottom portion of the screen to reveal the Attachment field
4. Then click on the attached file

Electrical Characteristics Summary:

Electrical characteristics are not impacted.

List of Affected Parts:

Note: Only the standard (off the shelf) part numbers are listed in the parts list. Any custom parts affected by this PCN are shown in the customer specific PCN addendum in the PCN email notification, or on the [PCN Customized Portal](#).

| Current Part Number | New Part Number | Qualification Vehicle |
|---------------------|-----------------|-----------------------|
| NCV1117DT15RKG | #NONE | NCV1117DT50RKG |
| NCV1117DT18RKG | #NONE | NCV1117DT50RKG |
| NCV1117DT18T5G | #NONE | NCV1117DT50RKG |
| NCV1117DT33T5G | #NONE | NCV1117DT50RKG |
| NCV1117DT50RKG | #NONE | NCV1117DT50RKG |
| NCV1117DTARKG | #NONE | NCV1117DT50RKG |
| NCV2931ADT5.0RKG | #NONE | NCV1117DT50RKG |
| NCV5501DT15RKG | #NONE | NCV1117DT50RKG |
| NCV5501DT33RKG | #NONE | NCV1117DT50RKG |
| NCV5501DT50RKG | #NONE | NCV1117DT50RKG |
| NCV33269DTRK3.3G | #NONE | NCV1117DT50RKG |
| NCV33269DTRK5.0G | #NONE | NCV1117DT50RKG |
| NCV33269DTRKG | #NONE | NCV1117DT50RKG |
| NCV78M05ABDTRKG | #NONE | NCV1117DT50RKG |
| NCV78M05BDTRKG | #NONE | NCV1117DT50RKG |
| NCV78M08BDTRKG | #NONE | NCV1117DT50RKG |
| NCV78M12BDTRKG | #NONE | NCV1117DT50RKG |
| NCV317MABDTRKG | #NONE | NCV1117DT50RKG |
| NCV317MBDTRKG | #NONE | NCV1117DT50RKG |
| NCV7805BDTRKG | #NONE | NCV1117DT50RKG |
| NCV7808BDTRKG | #NONE | NCV1117DT50RKG |



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| SA317MBDTRKG | #NONE | NCV1117DT50RKG |
| NCV1117DT12RKG | #NONE | NCV1117DT50RKG |
| NCV8664CDT50RKG | #NONE | NCV4274CDT50RKG |
| NCV4274ADT50RKG | #NONE | NCV4274ADT50RKG-IR01 |
| NCV4274ADT50RKG-IR01 | #NONE | NCV4274ADT50RKG-IR01 |
| NCV8664DT50RKG | #NONE | NCV4274ADT50RKG-IR01 |
| NCV4274CDT33RKG | #NONE | NCV4274CDT50RKG |
| NCV4274CDT50RKG | #NONE | NCV4274CDT50RKG |
| NCV8664CDT33RKG | #NONE | NCV4274CDT50RKG |
| SA317MDTRKG | #NONE | NCV1117DT50RKG |